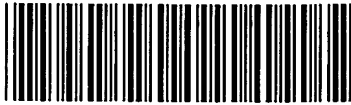


Search Notes

Application/Control No.

10/749,565

Examiner

Patricia Leith

Applicant(s)/Patent under
Reexamination

LO ET AL.

Art Unit

1655

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBKFILE	4/12/2006	PL